

## 1. Description

The KIA-8103A is the highest performance trench N-ch MOSFETs with extreme high cell density, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications. The KIA30N03B meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

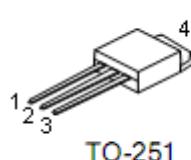
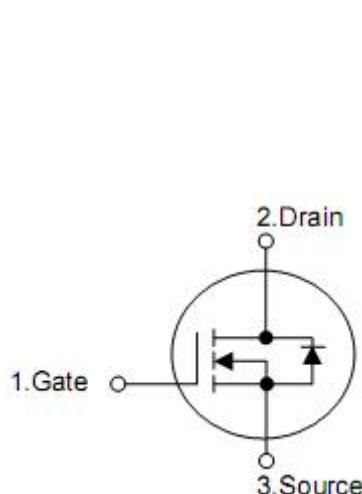
## 2. Features

- $R_{DS(on)} = 15\text{m}\Omega$  @  $V_{DS} = 30\text{V}$
- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent Cdv/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

## 3. Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

## 4. Symbol



Pin	Function
1	Gate
2	Drain
3	Source

## 5. Ordering Information

Part Number	Package	Brand
KND9120A	TO-252	KNX
KNU9120A	TO-251	KNX

## 6. Absolute maximum ratings

Parameter	Symbol	Rating	Units
Drain-source voltage	$V_{DS}$	30	V
Gate-source voltage	$V_{GS}$	+20	V
Continuous drain current, $V_{GS} @ 10V^1$	$I_D$	30	A
$T_C=25^\circ C$		18	A
Pulsed drain current <sup>2</sup>	$I_{DM}$	60	A
Single pulse avalanche energy <sup>3</sup>	$E_{AS}$	72	mJ
Avalanche current	$I_{AS}$	21	A
Total power dissipation <sup>4</sup>	$P_D$	25	W
Operation junction temperature range	$T_J$	-55 to 150	°C
Storage temperature range	$T_{STG}$	-55 to 150	°C

## 7. Thermal characteristics

Parameter	Symbol	Typ	Max	Unit
Thermal resistance,Junction-ambient( $t \leq 10s$ ) <sup>1</sup>	$R_{\theta JA}$	--	25	°C/W
Thermal resistance,Junction-ambient (Steady State) <sup>1</sup>	$R_{\theta JA}$	--	62	°C/W
Thermal resistance,Junction-case <sup>1</sup>	$R_{\theta JC}$	--	5	°C/W

## 8. Electrical characteristics

( $T_J=25^\circ\text{C}$ , unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Drain-source breakdown voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	30	-	-	V
$\text{BV}_{\text{DSS}}$ temperature coefficient	$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Reference to $25^\circ\text{C}$ , $I_{\text{D}}=1\text{mA}$		0.023		$\text{V}/^\circ\text{C}$
Static drain-source on-resistance <sup>2</sup>	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=10\text{A}$		15	18	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=5\text{A}$		22	30	
Gate threshold voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	1.0	1.5	2.5	V
$V_{\text{GS}(\text{th})}$ temperature coefficient	$\Delta V_{\text{GS}(\text{th})}$			-5.2		$\text{mV}/^\circ\text{C}$
Drain-source leakage current	$I_{\text{DSS}}$	$V_{\text{DS}}=24\text{V}, V_{\text{GS}}=0\text{V}$ $T_J=25^\circ\text{C}$			1	$\mu\text{A}$
		$V_{\text{DS}}=24\text{V}, V_{\text{GS}}=0\text{V}$ $T_J=55^\circ\text{C}$			5	$\mu\text{A}$
Gate- source leakage current	$I_{\text{GSS}}$	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$			$\pm 100$	nA
Forward transconductance	$g_{\text{fs}}$	$V_{\text{DS}}=15\text{V}, I_{\text{D}}=10\text{A}$		10		S
Gate resistance	$R_g$	$V_{\text{DS}}=24\text{V},$ $V_{\text{GS}}=0\text{V}, f=1\text{MHz}$		2.5	5	$\Omega$
Total gate charge(4.5V)	$Q_g$	$V_{\text{DS}}=20\text{V}, V_{\text{GS}}=4.5\text{V}$ $I_{\text{D}} = 12\text{A}$	-	7.2		nC
Gate-source charge	$Q_{\text{gs}}$			1.4		
Gate-drain charge	$Q_{\text{gd}}$			2.2		
Turn-on delay time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}}=12\text{V}, I_{\text{D}}=5\text{A},$ $R_G=3.3\Omega, V_{\text{GS}}=10\text{V}$		4.1		ns
Rise time	$t_r$			9.8		
Turn-off delay time	$t_{\text{d}(\text{off})}$			15.5		
Fall time	$t_f$			6.0		
Input capacitance	$C_{\text{iss}}$	$V_{\text{DS}}=15\text{V}, V_{\text{GS}}=0\text{V},$ $f=1\text{MHz}$		572		pF
Output capacitance	$C_{\text{oss}}$			81		
Reverse transfer capacitance	$C_{\text{rss}}$			65		
Single pulse avalanche energy <sup>5</sup>	EAS	$V_{\text{DD}}=25\text{V}, L=0.1\text{mH},$ $I_{\text{AS}}=10\text{A}$	16			mJ
Continuous source current <sup>1,6</sup>	$I_s$	$V_G= V_{\text{D}}=0\text{V},$ Force current			30	A
Pulsed source current <sup>2,6</sup>	$I_{\text{SM}}$				60	A
Diode forward voltage <sup>2</sup>	$V_{\text{SD}}$	$V_{\text{GS}}=0\text{V}, I_{\text{S}}=15\text{A}, T_J=25^\circ\text{C}$			1.2	V

Note:1.The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 20Z copper.

2.The data tested by pulsed, pulse width $\leq 300\mu\text{s}$ ,duty cycle $\leq 2\%$

3.The EAS data shows Max.rating.The test condition is  $V_{\text{DD}}=25\text{V}, V_{\text{GS}}=10\text{V}, L=0.1\text{mH}, I_{\text{AS}}=21\text{A}$

4.The power dissipation is limited by  $150^\circ\text{C}$  junction temperature

5.The Min. value is 100% EAS tested guarantee.

6.The data is theoretically the same as  $I_{\text{D}}$  and  $I_{\text{DM}}$ ,in real applications, should be limited by total power dissipation.

## 9. Test circuits and waveforms

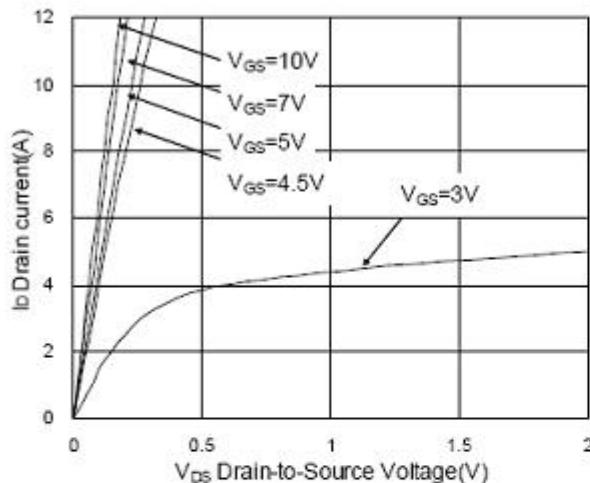


Fig.1 Typical Output Characteristics

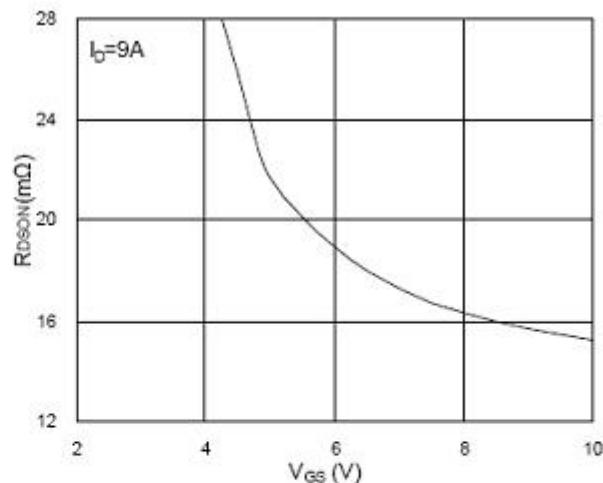


Fig.2 On-Resistance v.s Gate-Source

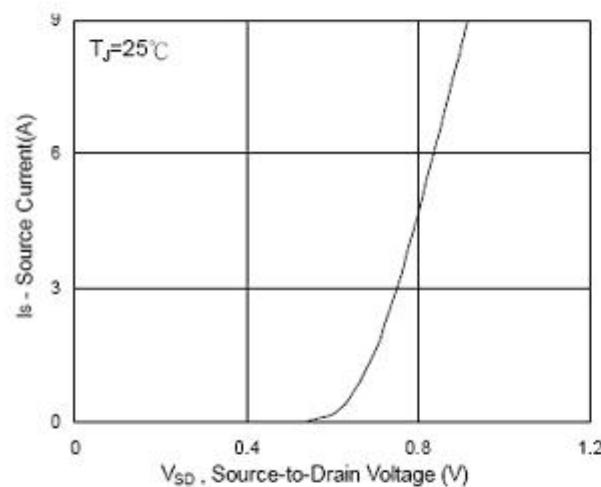


Fig.3 Forward Characteristics of Reverse

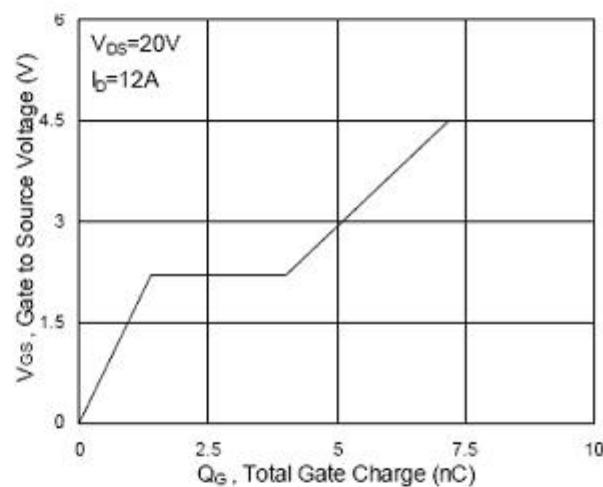


Fig.4 Gate-Charge characteristics

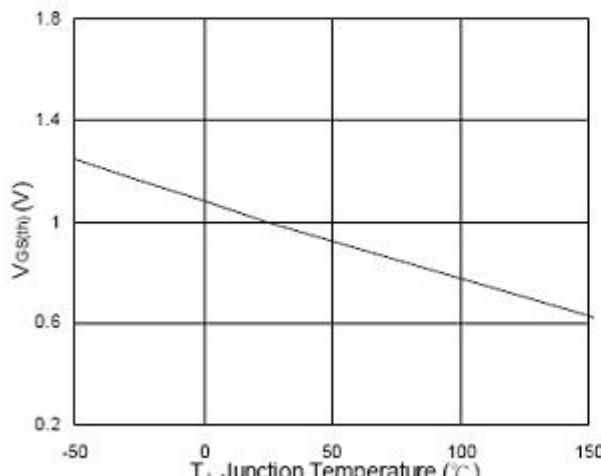


Fig.5 Normalized  $V_{GS(th)}$  v.s  $T_J$

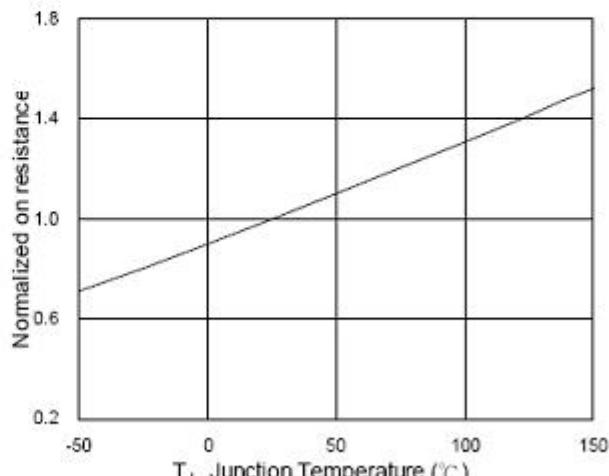
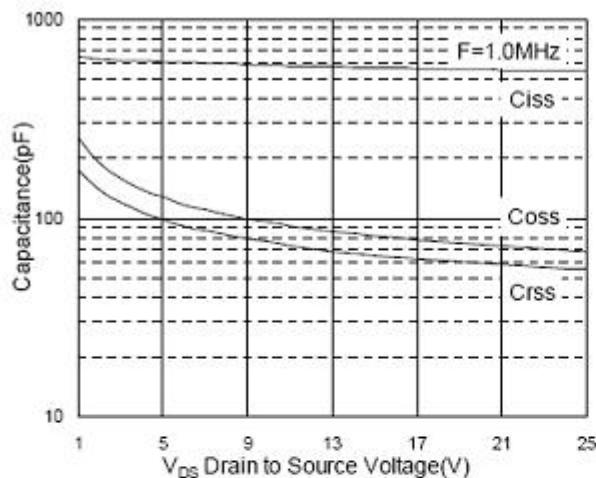
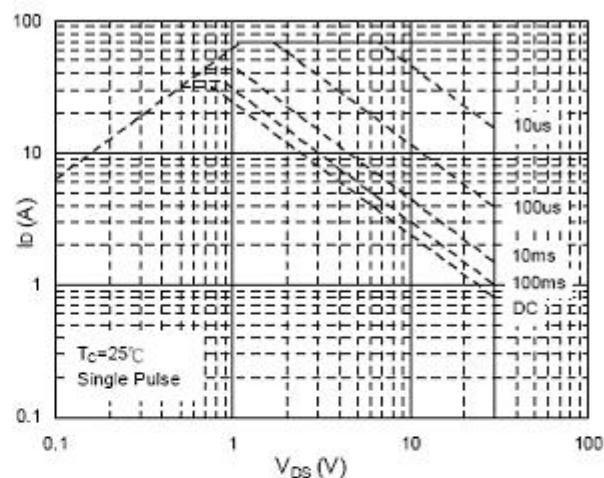


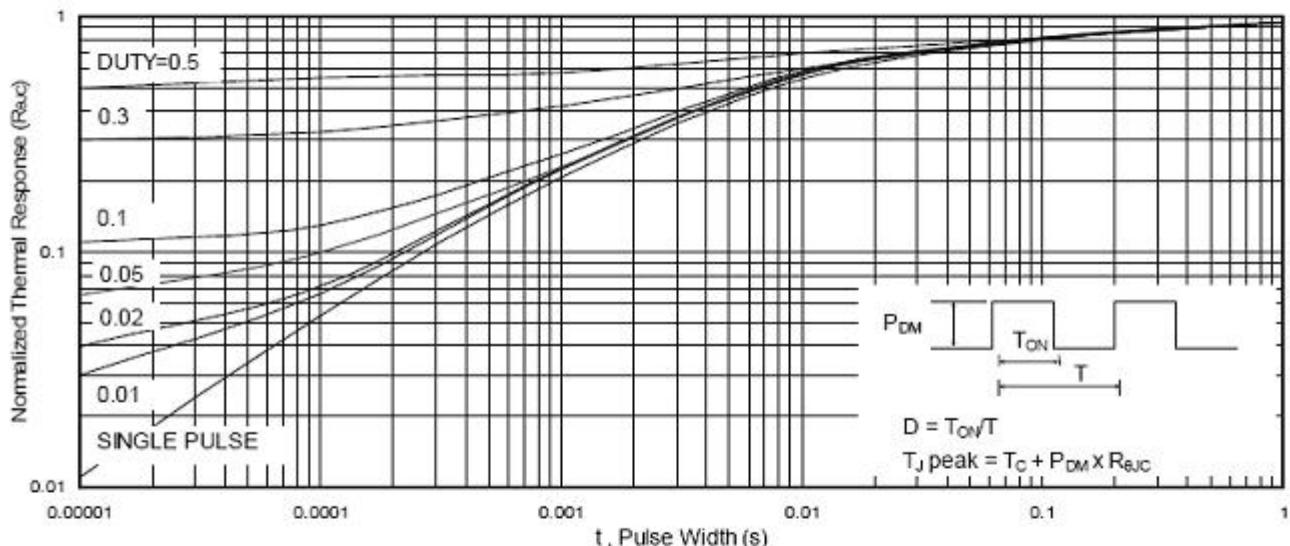
Fig.6 Normalized  $R_{DS(on)}$  v.s  $T_J$



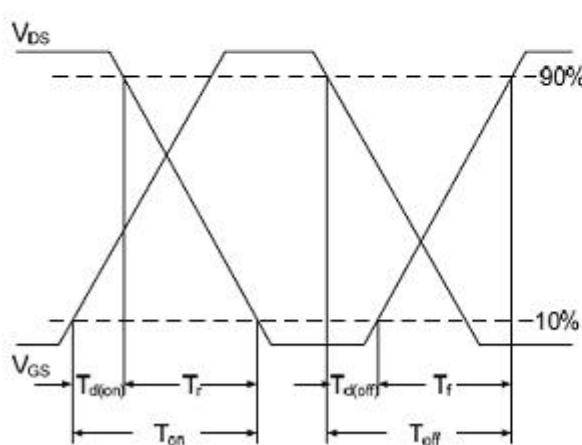
**Fig.7 Capacitance**



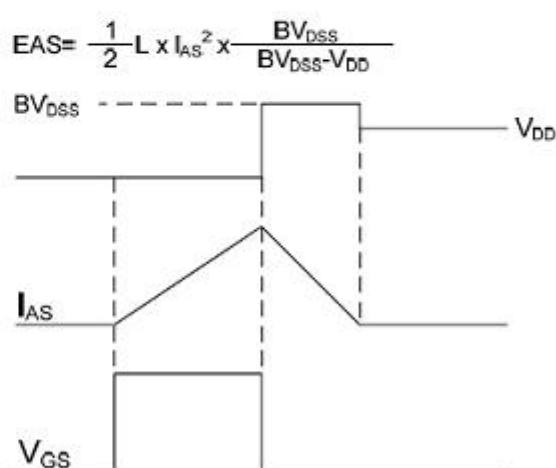
**Fig.8 Safe Operating Area**



**Fig.9 Normalized Maximum Transient Thermal Impedance**



**Fig.10 Switching Time Waveform**



**Fig.11 Unclamped Inductive Switching Waveform**